


<b>Search Notes</b>  	<b>Application/Control No.</b>  10552947	<b>Applicant(s)/Patent Under Reexamination</b>  BARKER, RICHARD J.
	<b>Examiner</b>  Nguyen, Hiep	<b>Art Unit</b>  2816

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST (see attachment)	03-14-08	Hn

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>